

ITEM P/N	PSPMAC0603H-330M-ANF	TEST INSTRUMENT	Zentech-3305 / Zentech502BC
PRODUCT	SMD INDUCTOR	TEST FREQUENCY	100 kHz / 1.0V

CUSTOMER :**CUSTOMER P/N :****DESCRIPTION :** SMD INDUCTOR**P/N :** PSPMAC0603H-330M-ANF**REVISION NO. :** Version:1.0**DATE :** 2016-1-13**NOTES :** STANDARD

DOCUMENTED	
APPROVED	Yuki
CHECKED	Ben
PREPARED	Peter

CUSTOMER APPROVAL

company seals



PROD TECHNOLOGY CO., LTD.

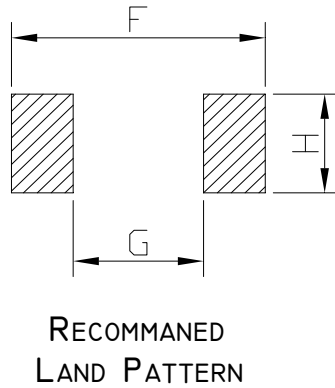
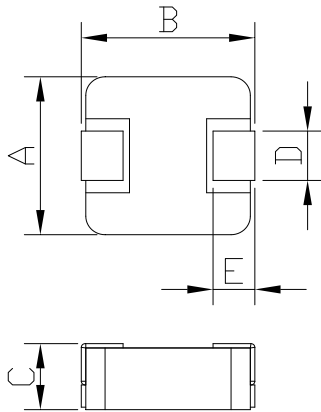
TEL : 0755-86667379

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E-LIVEN TECHNOLOGY CO., LTD.

NO.28 ho-cheng RD, bade city, taoyuan,
taiwan

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PACKING DIMENSIONS (mm)

0603	Dimensions
A	6.6 ± 0.3
B	7.1 ± 0.3
C	3.0 MAX
D	3.0 ± 0.3
E	1.6 ± 0.5
G	7.4 Typ
H	3.7 Typ
I	3.5 Typ

EXPLANATION OF PART NUMBERS

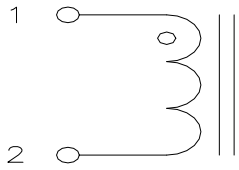
P S P M A A 0 6 0 3 H	-	3 3 0 M	-	A N F
<u>Serial Codes</u>		<u>Inductance Code</u>		<u>Description</u>
		<u>Size</u>		

ELECTRICAL CHARACTERISTICS

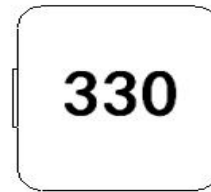
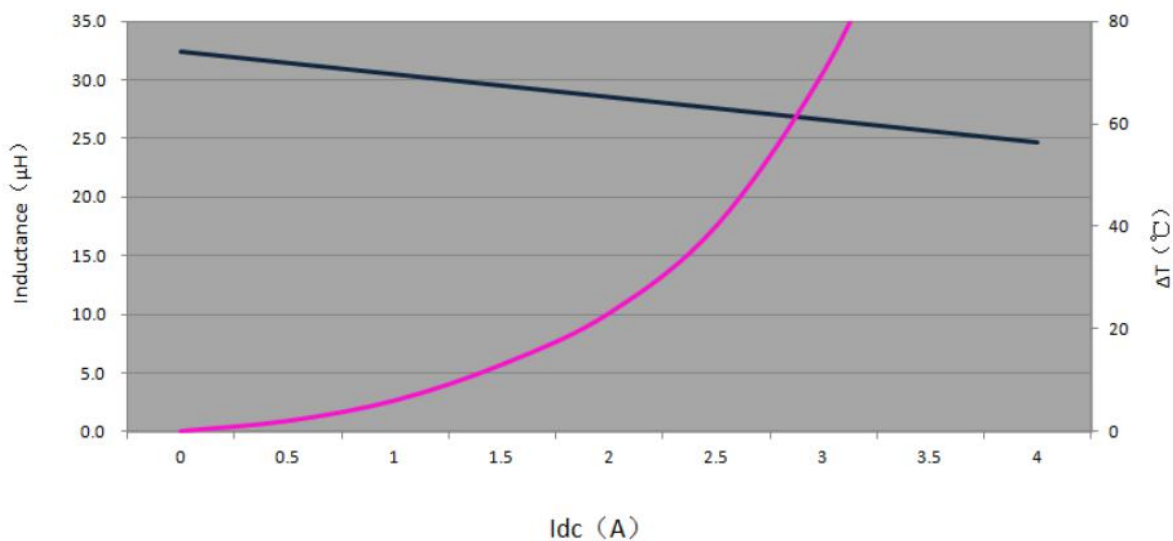
ITEM P/N	@ 25°C Ambient Temperature					
	INDUCTANCE		I _{rms} (A) Max.	I _{sat} (A) Max.	DCR (mΩ) Typical	DCR (mΩ) MAX
	Lo (μH)	TOLERANCE				
PSPMAC0603H-330M-ANF	33.00	±20%	2	3	210.0	250.0

- ⊙ All test Data is referenced to 25°C ambient
- ⊙ Typical Heat Rating DC Current would cause an approximately ΔT of 40°C
- ⊙ Typical Saturation DC Current would cause Lo to drop approximately 35%
- ⊙ Operation Temperature Range : -40°C ~ 125°C
- ⊙ The Part temperature (ambient + ΔT) should not exceed 125°C under worst case operating conditions.
- ⊙ Circuit design, component placement, PWB trace size and thickness, airflow and other cooling provisions all effect the part temperature. Part temperature should be verified in the end application.

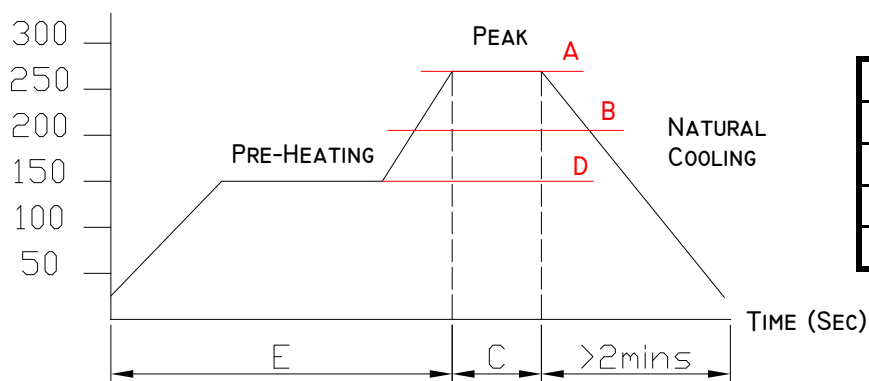
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Schematic Diagram:

- ⊙ Inductor Contents ONE (1) Set(s) of Coil
- ⊙ DC/AC Current Shall Be Introduced By Any One of Two Pads

MARKING**PERFORMANCE CURVES:****RECOMMENDED SOLDERING TEMP. GRAPH**

TEMPERATURE (°C)



A	260°C
B	230°C
C	10 Sec
D	150°C
E	60~240 Sec

Page: 2

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MECHANICAL RELIABILITY

TEST	Specification & Requirement	Method Used
Solderability	The surface of terminal/pin tested shall be covered with new solder by 95%	Solder heat proof: Preheating: 180 ±10°C 90 seconds Soldering: 255 ±5°C for 3 ±1 sec
Shock	Inductance change within ± 5% Without mechanical damage	Drop down with 981m/s2 (100G) shock Attitude upon a rubber block method shock testing machinem, 3 tests.
Vibration	Inductance change within ± 5% Without mechanical damage	Vibration frequency: 10Hz to 55Hz to 10Hz 60 seconds cycle Vibration time: 2 hours

ENDURANCE RELIABILITY

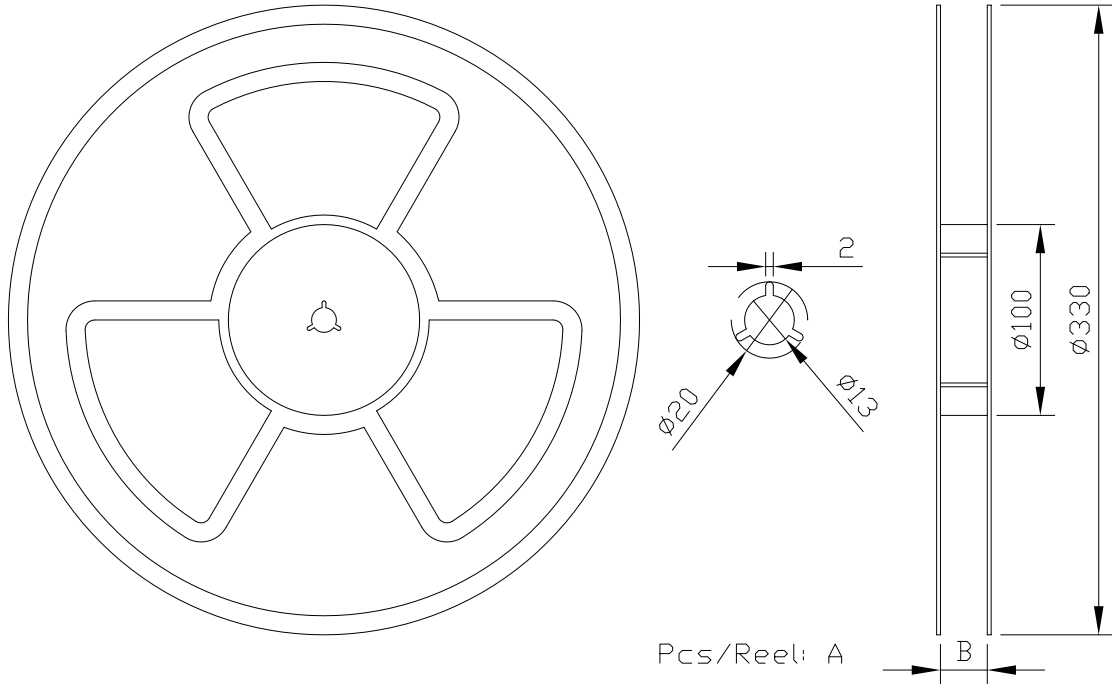
TEST	Specification & Requirement	Method Used
Thermal Shock	Inductance change within ± 5% Without mechanical damage	-25°C, (30 mins) -> room temp. (5 mins) -> 125°C, (30 mins) -> room temp. (5 mins) 100 cycles
Heat Resistance	Inductance change within ± 5% Without mechanical damage	Apply IDC current @ 85°C ambient Duration: 1000 hrs
Humidity Resistance	Inductance change within ± 5% Without mechanical damage	Apply IDC current @ 60°C ambient Humidity: 90~95% Duration: 1000 hrs
Low Temp. Storing	Inductance change within ± 5% Without mechanical damage	Storing Temp. -25 ±2 °C for total 1,000 +4/-0 hours
High Temp. Storing	Inductance change within ± 5% Without mechanical damage	Storing Temp. 125 ±2 °C for total 1,000 +4/-0 hours

PACKING FOR SMD

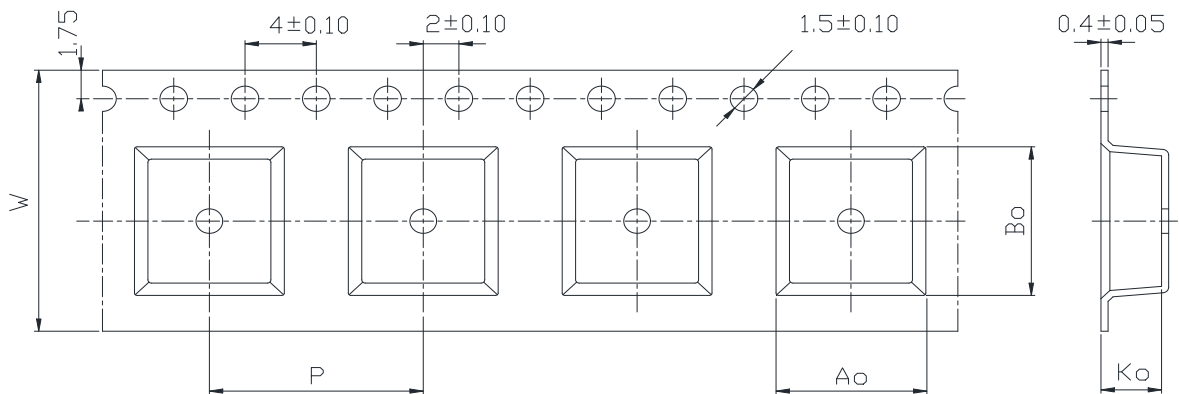
**RoHS
COMPLIANT**

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CARRIERTAPEING REEL & CARRIER MATERIALS (PAPER PLASTICS) UNIT : (mm)

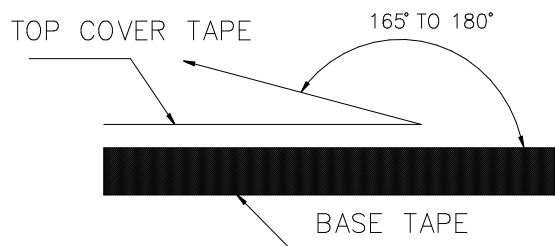


A	B	Ao	Bo	Ko
1000	17	6.9 ± 0.1	7.6 ± 0.1	4.3 ± 0.1



W	P
16	12

Typical Pulling Force:
10 grams



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TEST DATA

SPEC No.	A (mm)	B (mm)	C (mm)	D (mm)	E (mm)	DCR Max(mΩ)	INDUCTANCE	
	6.6 ± 0.3	7.1 ± 0.3	3.0 MAX	3.0 ± 0.3	1.6 ± 0.5		L(0)±20%	3 A ≈65% L(0)
1	6.61	7.41	2.89	3.03	1.65	205.30	32.16	PASS
2	6.69	7.43	2.95	3.06	1.62	205.60	32.25	PASS
3	6.65	7.46	2.94	3.16	1.64	205.40	32.65	PASS
4	6.63	7.41	2.96	3.12	1.63	205.90	32.24	PASS
5	6.62	7.42	2.91	3.05	1.69	205.10	32.59	PASS
6	6.65	7.43	2.92	3.08	1.61	205.30	32.58	PASS
7	6.61	7.45	2.93	3.14	1.62	205.10	32.16	PASS
8	6.63	7.41	2.89	3.12	1.65	205.40	33.16	PASS
9	6.64	7.40	2.86	3.16	1.64	205.60	33.18	PASS
10	6.62	7.42	2.88	3.19	1.63	205.50	32.64	PASS
\bar{X}	6.64	7.42	2.91	3.11	1.64	205.42	32.56	
R	0.08	0.06	0.10	0.16	0.08	0.80	1.02	

© All test Data is referenced to 25°C ambient

产品注意事项

使用本产品时，请注意以下事项

- ◎ 产品保存期限为12个月，保存条件：温度5~40℃，湿度10~80%RH以内，超过保存期限可能会使产品端子电极发生氧化。
- ◎ 请勿在极端环境下使用和保存（高盐，强酸，强碱，强辐射等）。
- ◎ 产品焊接前，请进行预热；预热温度与焊接温度之间温差建议控制在150℃以内。
- ◎ 产品焊接后需重新拆卸焊接修正时，请遵循规格书规定的条件范围；过高的加热温度以及反复的拆卸可能会导致产品失效。
- ◎ 产品焊接到线路板后，请注意不可因线路板整体变形或局部变形而施加给电感剩余应力，这可能会导致电感发生破裂，脱落，以致失效。
- ◎ 产品请勿接触清洗剂，酒精等液体，这会侵蚀产品本体，从而导致产品失效。
- ◎ 产品通电后温度会随电流的增大而上升，设计时请务必考虑留有余量。
- ◎ 过高的静电会对产品产生永久性损害，请注意静电防护。
- ◎ 产品通电过程请勿触摸产品任何部位，防止触电。
- ◎ 本产品作为磁性产品，设计时请务必考虑周边元器件与本产品可能产生的相互影响。
- ◎ 本产品适用于一般电子设备，如：AV设备，通信设备，家电产品，娱乐设备，计算机设备，个人设备，办公设备，计测设备，工业机器人等。且该一般电子设备需在常规的操作和使用方法环境下使用。对于需要高度安全性和可靠性的，或者因本产品失效造成设备故障，误操作，运转不良等危及到人的生命身体及财产安全，以及对社会产生较大不良影响的特殊用途，设计使用前务必同本公司沟通，设计使用者如在未取得我司书面同意状况下使用造成任何后果，我司不予承担。特殊用途包含但不限于如下清单：

- | | |
|-----------------------|------------------|
| 1 军用设备 | 8 关系到国防安全的设备 |
| 2 运输设备（汽车，轨道交通产品，船舶等） | 9 防灾赈灾设备 |
| 3 航空，航天设备 | 10 各种安规设备 |
| 4 发电控制设备 | 11 紧急救护设备 |
| 5 核动力相关设备 | 12 其他被认定为特殊用途的设备 |
| 6 爆炸引燃控制设备 | |
| 7 交通控制设备 | |